

SN54ALS873B, SN54AS873, SN74ALS873B, SN74AS873A DUAL 4-BIT D-TYPE LATCHES WITH 3-STATE OUTPUTS

SDAS036C – APRIL 1982 – REVISED SEPTEMBER 1994

- 3-State Buffer-Type Outputs Drive Bus Lines Directly
- Bus-Structured Pinout
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Plastic (NT) and Ceramic (JT) DIPs

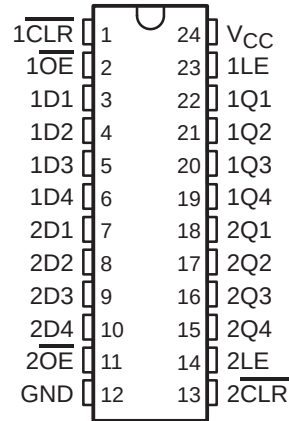
description

These dual 4-bit D-type latches feature 3-state outputs designed specifically for bus driving. This makes these devices particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

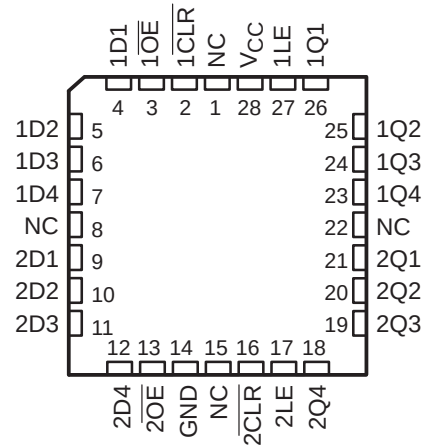
The dual 4-bit latches are transparent D-type latches. While the latch-enable (LE) input is high, the Q outputs follow the data (D) inputs in true form, according to the function table. When LE is low, the outputs are latched. When the clear (CLR) input goes low, the Q outputs go low independently of LE. The outputs are in a high-impedance state when the output-enable ($\overline{OE}$) input is at a high logic level.

The SN54ALS873B and SN54AS873 are characterized for operation over the full military temperature range of -55°C to 125°C . The SN74ALS873B and SN74AS873A are characterized for operation from 0°C to 70°C .

SN54ALS873B, SN54AS873 . . . JT PACKAGE
SN74ALS873B, SN74AS873A . . . DW OR NT PACKAGE
(TOP VIEW)



SN54ALS873B, SN54AS873 . . . FK PACKAGE
(TOP VIEW)



NC – No internal connection

FUNCTION TABLE
(each latch)

INPUTS				OUTPUT Q
$\overline{OE}$	$\overline{CLR}$	LE	D	
L	L	X	X	L
L	H	H	H	H
L	H	H	L	L
L	H	L	X	Q_0
H	X	X	X	Z

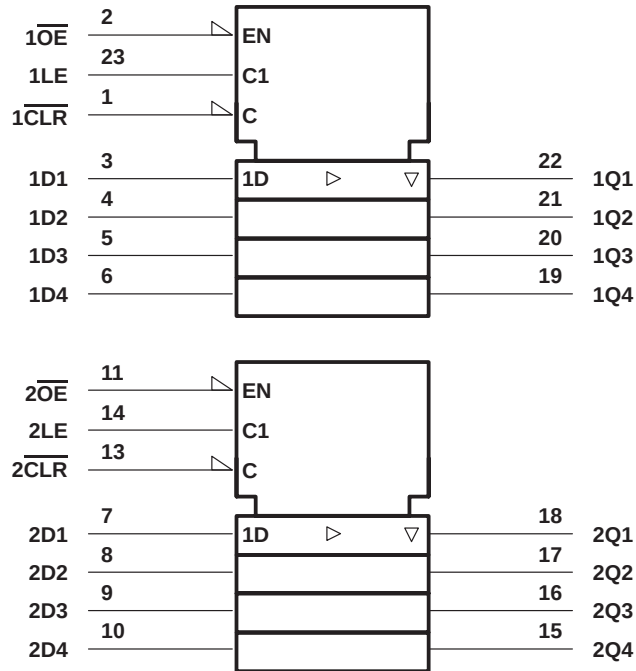
SN54ALS873B, SN54AS873, SN74ALS873B, SN74AS873A

DUAL 4-BIT D-TYPE LATCHES

WITH 3-STATE OUTPUTS

SDAS036C – APRIL 1982 – REVISED SEPTEMBER 1994

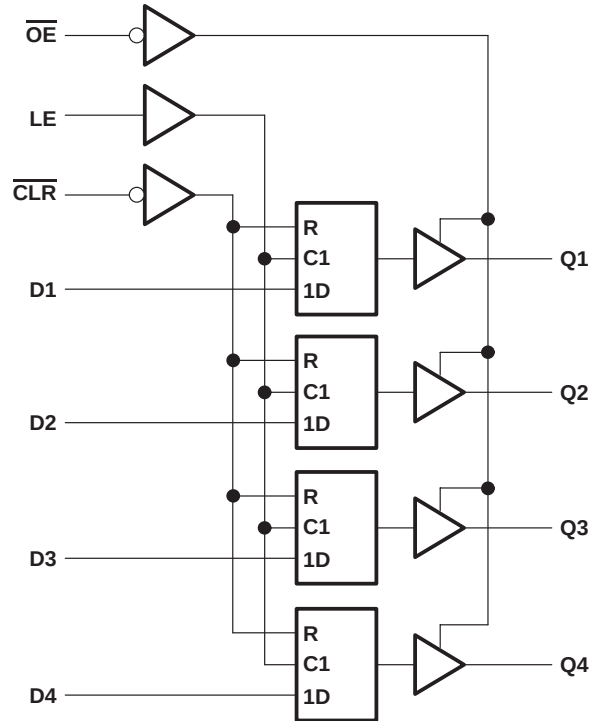
logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the DW, JT, and NT packages.

logic diagram (each quad latch, positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V_{CC}	7 V
Input voltage, V_I	7 V
Voltage applied to a disabled 3-state output	5.5 V
Operating free-air temperature range, T_A : SN54ALS873B	–55°C to 125°C
SN74ALS873B	0°C to 70°C
Storage temperature range	–65°C to 150°C

‡ Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		SN54ALS873B			SN74ALS873B			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.7			0.8	V
I_{OH}	High-level output current			–1			–2.6	mA
I_{OL}	Low-level output current			12			24	mA
T_A	Operating free-air temperature	–55		125	0		70	°C



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SDAS036C – APRIL 1982 – REVISED SEPTEMBER 1994

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54ALS873B			SN74ALS873B			UNIT
			MIN	TYP†	MAX	MIN	TYP†	MAX	
V _{IK}	V _{CC} = 4.5 V, I _I = −18 mA		−1.2			−1.2			V
V _{OH}	V _{CC} = 4.5 V to 5.5 V, I _{OH} = −0.4 mA		V _{CC} − 2			V _{CC} − 2			V
	V _{CC} = 4.5 V	I _{OH} = −1 mA	2.4	3.3					
		I _{OH} = −2.6 mA			2.4	3.2			
V _{OL}	V _{CC} = 4.5 V	I _{OL} = 12 mA	0.25		0.4	0.25	0.4	V	
		I _{OL} = 24 mA			0.35	0.5			
I _{OZH}	V _{CC} = 5.5 V, V _O = 2.7 V		20			20			μA
I _{OZL}	V _{CC} = 5.5 V, V _O = 0.4 V		−20			−20			μA
I _I	V _{CC} = 5.5 V, V _I = 7 V		0.1			0.1			mA
I _{IH}	V _{CC} = 5.5 V, V _I = 2.7 V		20			20			μA
I _{IL}	V _{CC} = 5.5 V, V _I = 0.4 V		−0.2			−0.2			mA
I _O ‡	V _{CC} = 5.5 V, V _O = 2.25 V		−20	−112		−30	−112		mA
I _{CC}	V _{CC} = 5.5 V	Outputs high	11	21	11	21	mA		
		Outputs low	16	29	16	29			
		Outputs disabled	20	31	20	31			

[†] All typical values are at $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$.

[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS} .

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

			SN54ALS873B		SN74ALS873B		UNIT
			MIN	MAX	MIN	MAX	
t_w	Pulse duration	$\overline{\text{CLR}}$ low	15		15		ns
		LE high	10		10		
t_{su}	Setup time, data before LE $\downarrow$		10		10		ns
t_h	Hold time, data after LE $\downarrow$		7		7		ns

SN54ALS873B, SN54AS873, SN74ALS873B, SN74AS873A

DUAL 4-BIT D-TYPE LATCHES

WITH 3-STATE OUTPUTS

SDAS036C – APRIL 1982 – REVISED SEPTEMBER 1994

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 4.5 V to 5.5 V, C _L = 50 pF, R ₁ = 500 Ω, R ₂ = 500 Ω, T _A = MIN to MAX [†]				UNIT
			SN54ALS873B		SN74ALS873B		
			MIN	MAX	MIN	MAX	
t _{PLH}	D	Q	2	23	2	14	ns
t _{PHL}			2	17	2	14	
t _{PLH}	LE	Q	8	31	8	22	ns
t _{PHL}			8	26	8	21	
t _{PHL}	$\overline{\text{CLR}}$	Q	6	27	6	20	ns
t _{PZH}	$\overline{\text{OE}}$	Q	4	24	4	18	ns
t _{PZL}			4	23	4	18	
t _{PHZ}	$\overline{\text{OE}}$	Q	2	12	2	10	ns
t _{PLZ}			2	30	2	15	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}	7 V
Input voltage, V _I	7 V
Voltage applied to a disabled 3-state output	5.5 V
Operating free-air temperature range, T _A : SN54AS873	–55°C to 125°C
SN74AS873A	0°C to 70°C
Storage temperature range	–65°C to 150°C

‡ Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		SN54AS873			SN74AS873A			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V _{IH}	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.8			0.8	V
I _{OH}	High-level output current			–12			–15	mA
I _{OL}	Low-level output current			32			48	mA
T _A	Operating free-air temperature	–55		125	0		70	°C



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54AS873			SN74AS873A			UNIT
			MIN	TYP†	MAX	MIN	TYP†	MAX	
V _{IK}	V _{CC} = 4.5 V, I _I = −18 mA		−1.2			−1.2			V
V _{OH}	V _{CC} = 4.5 V to 5.5 V, I _{OH} = −2 mA		V _{CC} − 2			V _{CC} − 2			V
	V _{CC} = 4.5 V	I _{OH} = −12 mA	2.4	3.2					
		I _{OH} = −15 mA			2.4	3.3			
V _{OL}	V _{CC} = 4.5 V	I _{OL} = 32 mA	0.25		0.5				V
		I _{OL} = 48 mA			0.35	0.5			
I _{OZH}	V _{CC} = 5.5 V, V _O = 2.7 V		50			50			μA
I _{OZL}	V _{CC} = 5.5 V, V _O = 0.4 V		−50			−50			μA
I _I	V _{CC} = 5.5 V, V _I = 7 V		0.1			0.1			mA
I _{IH}	V _{CC} = 5.5 V, V _I = 2.7 V		20			20			μA
I _{IL}	V _{CC} = 5.5 V, V _I = 0.4 V		−0.5			−0.5			mA
I _O ‡	V _{CC} = 5.5 V, V _O = 2.25 V		−30	−112		−30	−112		mA
I _{CC}	V _{CC} = 5.5 V	Outputs high	68	110		68	110		mA
		Outputs low	67	109		67	109		
		Outputs disabled	80	129		80	129		

[†] All typical values are at $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$.

[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS} .

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

			SN54AS873		SN74AS873A		UNIT
			MIN	MAX	MIN	MAX	
t_w^*	Pulse duration	$\overline{\text{CLR}}$ low	5		5		ns
		LE high	6		5		
t_{su}^*	Setup time, data before LE $\downarrow$		2		2		ns
t_h^*	Hold time, data after LE $\downarrow$		4.5		4.5		ns

* On products compliant to MIL-STD-883, Class B, these parameters are based on characterization data but are not production tested.

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switching characteristics (see Figure 1)

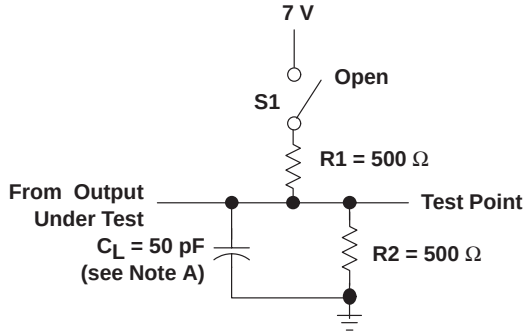
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 4.5 V to 5.5 V, C _L = 50 pF, R1 = 500 Ω, R2 = 500 Ω, T _A = MIN to MAX [†]				UNIT
			SN54AS873		SN74AS873A		
			MIN	MAX	MIN	MAX	
t _{PLH}	D	Q	3	9	3	9.5	ns
t _{PHL}			3	7	3	7.5	
t _{PLH}	LE	Q	6	14	6	13	ns
t _{PHL}			4	9	4	7.5	
t _{PHL}	$\overline{\text{CLR}}$	Q	3	10	3	9	ns
t _{PZH}	$\overline{\text{OE}}$	Q	2	8	2	6.5	ns
t _{PZL}			4	11	4	10.5	
t _{PHZ}	$\overline{\text{OE}}$	Q	2	8	2	7.5	ns
t _{PLZ}			2	8.5	2	7.5	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

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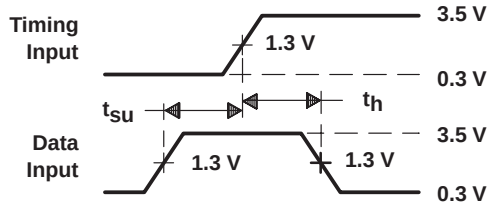
PARAMETER MEASUREMENT INFORMATION



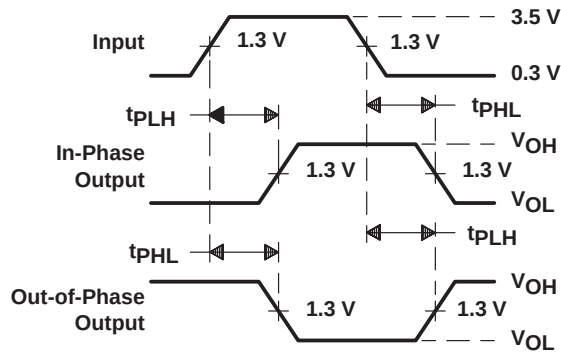
SWITCH POSITION TABLE

TEST	S1
t_{PLH}	Open
t_{PHL}	Open
t_{PZH}	Open
t_{PZL}	Closed
t_{PHZ}	Open
t_{PLZ}	Closed

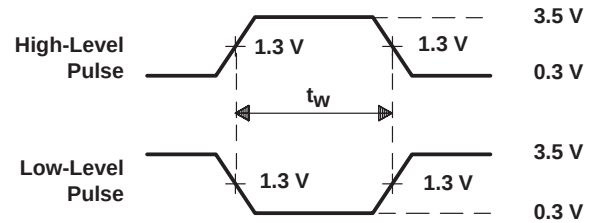
LOAD CIRCUIT FOR 3-STATE OUTPUTS



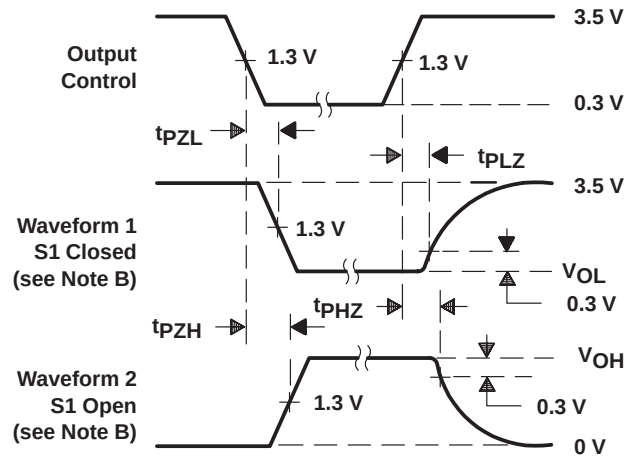
VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES



VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES



VOLTAGE WAVEFORMS
PULSE DURATION



VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES, 3-STATE OUTPUTS

- NOTES: A. C_L includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: $PRR \leq 1 \text{ MHz}$, $Z_O = 50 \Omega$, $t_r \leq 2 \text{ ns}$, $t_f \leq 2 \text{ ns}$.
D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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